

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

PATENT NO. : 6,862,161 B2  
DATED : March 1, 2005  
INVENTOR(S) : Woo

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page,

Item [56], **References Cited**, insert the following:

-- OTHER PUBLICATIONS

Duvvury et al., "ESD Protection: Design and Layout Issues for VLSI Circuits," IEEE Transactions on Industry Application, vol. 25 no. 1, January/February 1989, pp. 41-47.

Keller, J. K., "Protection of MOS Integrated Circuits from Destruction by Electrostatic Discharge," IIT Research Institute, 1981, pp. 73-80.

Hulett, T.V., "On Chip Protection of High Density NMOS Devices," pp. 90-96.

Protective Device, at <http://www.delphion.com/tdbs/tdb?&order=85A+61067>, IBM Technical Disclosure Bulletin, April 1985, pp. 6814-6815. --.

Signed and Sealed this

Sixteenth Day of August, 2005

A handwritten signature in black ink, appearing to read "Jon W. Dudas". The signature is stylized with a large, looped initial "J" and a distinct "D".

JON W. DUDAS

*Director of the United States Patent and Trademark Office*